

<b>Notice of References Cited</b>	Application/Control No. 10/660,530	Applicant(s)/Patent Under Reexamination YEN, SHIOW-KANG	
	Examiner William T. Leader	Art Unit 1742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,480,438	01-1996	Arima et al.	623/23.6
	B	US-5,723,038	03-1998	Scharnweber et al.	205/107
	C	US-5,759,376	06-1998	Teller et al.	205/50
	D	US-6,645,644	11-2003	Schwartz et al.	428/632
	E	US-2003/0099762	05-2003	Zhang et al.	427/2.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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